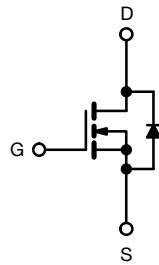
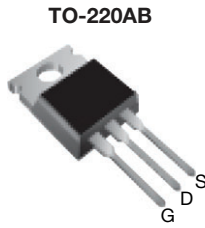


Power MOSFET



N-Channel MOSFET

FEATURES

- Ultra low gate charge
- Reduced gate drive requirement
- Enhanced 30 V V_{GS} rating
- Reduced C_{iss} , C_{oss} , C_{rss}
- Extremely high frequency operation
- Repetitive avalanche rated
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

This new series of low charge power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing the new LCDMOS technology, the device improvements are achieved without added product cost, allowing for reduced gate drive requirements and total system savings. In addition, reduced switching losses and improved efficiency are achievable in a variety of high frequency applications. Frequencies of a few MHz at high current are possible using the new low charge MOSFETs.

These device improvements combined with the proven ruggedness and reliability that are characteristic of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

PRODUCT SUMMARY

| | | |
|---------------------------|-----------------|------|
| V_{DS} (V) | 500 | |
| $R_{DS(on)}$ (Ω) | $V_{GS} = 10$ V | 0.85 |
| Q_g max. (nC) | 39 | |
| Q_{gs} (nC) | 10 | |
| Q_{gd} (nC) | 19 | |
| Configuration | Single | |

ORDERING INFORMATION

| | |
|---------------------------------|-----------------|
| Package | TO-220AB |
| Lead (Pb)-free | IRF840LCPbF |
| Lead (Pb)-free and halogen-free | IRF840LCPbF-BE3 |

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise noted)



| PARAMETER | SYMBOL | LIMIT | UNIT |
|---|------------------|---|---------------------|
| Drain-source voltage | V_{DS} | 500 | V |
| Gate-source voltage | V_{GS} | ± 30 | |
| Continuous drain current | I_D | V_{GS} at 10 V $T_C = 25^\circ\text{C}$ | 8.0 |
| | | $T_C = 100^\circ\text{C}$ | 5.1 |
| Pulsed drain current ^a | I_{DM} | 28 | A |
| Linear derating factor | | 1.0 | W/ $^\circ\text{C}$ |
| Single pulse avalanche energy ^b | E_{AS} | 510 | mJ |
| Repetitive avalanche current ^a | I_{AR} | 8.0 | A |
| Repetitive avalanche energy ^a | E_{AR} | 13 | mJ |
| Maximum power dissipation | P_D | 125 | W |
| Peak diode recovery dV/dt ^c | dV/dt | 3.5 | V/ns |
| Operating junction and storage temperature range | T_J, T_{stg} | -55 to +150 | $^\circ\text{C}$ |
| Soldering recommendations (peak temperature) ^d | For 10 s | 300 | |
| Mounting torque | 6-32 or M3 screw | | 10 |
| | | | 1.1 |
| | | | lbf · in |
| | | | N · m |

Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- $V_{DD} = 50$ V, starting $T_J = 25^\circ\text{C}$, $L = 14$ mH, $R_g = 25 \Omega$, $I_{AS} = 8.0$ A (see fig. 12)
- $I_{SD} \leq 8.0$ A, $dI/dt \leq 100$ A/ μs , $V_{DD} \leq V_{DS}$, $T_J \leq 150^\circ\text{C}$
- 1.6 mm from case



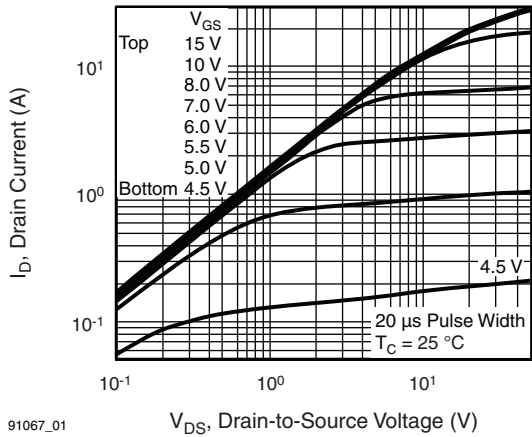
| THERMAL RESISTANCE RATINGS | | | | |
|-------------------------------------|------------|------|------|------|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
| Maximum junction-to-ambient | R_{thJA} | - | 62 | °C/W |
| Case-to-sink, flat, greased surface | R_{thCS} | 0.50 | - | |
| Maximum junction-to-case (drain) | R_{thJC} | - | 1.0 | |

| SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | | | | |
|---|---------------------|--|---|------|------|-----------|---------------|
| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
| Static | | | | | | | |
| Drain-source breakdown voltage | V_{DS} | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$ | | 500 | - | - | V |
| V_{DS} temperature coefficient | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^\circ\text{C}$, $I_D = 1\text{ mA}$ | | - | 0.63 | - | V/°C |
| Gate-source threshold voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$ | | 2.0 | - | 4.0 | V |
| Gate-source leakage | I_{GSS} | $V_{GS} = \pm 20\text{ V}$ | | - | - | ± 100 | nA |
| Zero gate voltage drain current | I_{DSS} | $V_{DS} = 500\text{ V}, V_{GS} = 0\text{ V}$ | | - | - | 25 | μA |
| | | $V_{DS} = 400\text{ V}, V_{GS} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$ | | - | - | 250 | |
| Drain-source on-state resistance | $R_{DS(on)}$ | $V_{GS} = 10\text{ V}$ | $I_D = 4.8\text{ A}^b$ | - | - | 0.85 | Ω |
| Forward transconductance | g_{fs} | $V_{DS} = 50\text{ V}, I_D = 4.8\text{ A}^b$ | | 4.0 | - | - | S |
| Dynamic | | | | | | | |
| Drain-source breakdown voltage | C_{iss} | $V_{GS} = 0\text{ V},$ $V_{DS} = 25\text{ V},$ $f = 1.0\text{ MHz}$, see fig. 5 | | - | 1100 | - | pF |
| V_{DS} temperature coefficient | C_{oss} | | | - | 170 | - | |
| Gate-source threshold voltage | C_{rSS} | | | - | 18 | - | |
| Gate-source leakage | Q_g | $V_{GS} = 10\text{ V}$ | $I_D = 8.0\text{ A}, V_{DS} = 400\text{ V}$ see fig. 6 and 13 ^b | - | - | 39 | nC |
| Zero gate voltage drain current | Q_{gs} | | | - | - | 10 | |
| | Q_{gd} | | | - | - | 19 | |
| Drain-source on-state resistance | $t_{d(on)}$ | $V_{DD} = 250\text{ V}, I_D = 8.0\text{ A},$ $R_g = 9.1\text{ }\Omega, R_D = 30\text{ }\Omega$ see fig. 10 ^b | | - | 12 | - | ns |
| Forward transconductance | t_r | | | - | 25 | - | |
| Drain-source breakdown voltage | $t_{d(off)}$ | | | - | 27 | - | |
| V_{DS} temperature coefficient | t_f | | | - | 19 | - | |
| Gate input resistance | R_g | $f = 1\text{ MHz}$, open drain | | 0.7 | - | 3.7 | Ω |
| Internal drain inductance | L_D | Between lead, 6 mm (0.25") from package and center of die contact  | | - | 4.5 | - | nH |
| Internal source inductance | L_S | | | - | 7.5 | - | |
| Drain-Source Body Diode Characteristics | | | | | | | |
| Continuous source-drain diode current | I_S | MOSFET symbol showing the integral reverse p - n junction diode  | | - | - | 8.0 | A |
| Pulsed diode forward current ^a | I_{SM} | | | - | - | 28 | |
| Body diode voltage | V_{SD} | $T_J = 25\text{ }^\circ\text{C}, I_S = 8.0\text{ A}, V_{GS} = 0\text{ V}^b$ | | - | - | 2.0 | V |
| Body diode reverse recovery time | t_{rr} | $T_J = 25\text{ }^\circ\text{C}, I_F = 8.0\text{ A},$ $di/dt = 100\text{ A}/\mu\text{s}^b$ | | - | 490 | 740 | ns |
| Body diode reverse recovery charge | Q_{rr} | | | - | 3.0 | 4.5 | |
| Forward turn-on time | t_{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | | |

Notes

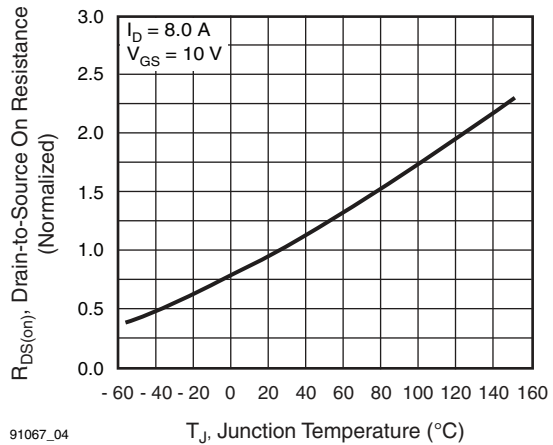
- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width $\leq 300\text{ }\mu\text{s}$; duty cycle $\leq 2\%$

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



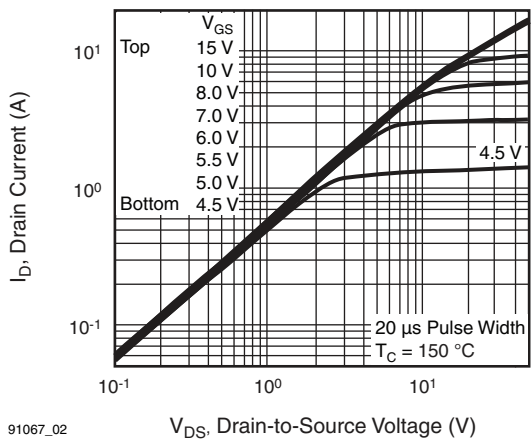
91067_01

Fig. 1 - Typical Output Characteristics, $T_C = 25\text{ }^\circ\text{C}$



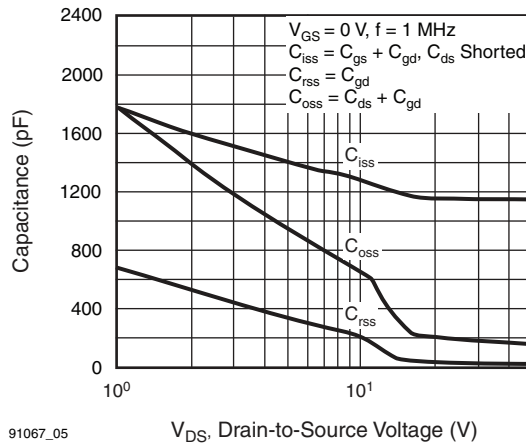
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Fig. 4 - Normalized On-Resistance vs. Temperature



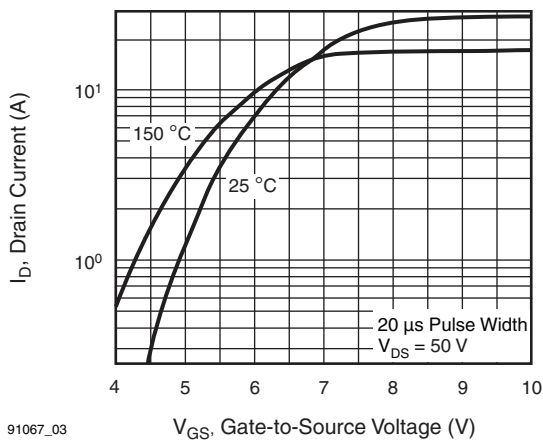
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Fig. 2 - Typical Output Characteristics, $T_C = 150\text{ }^\circ\text{C}$



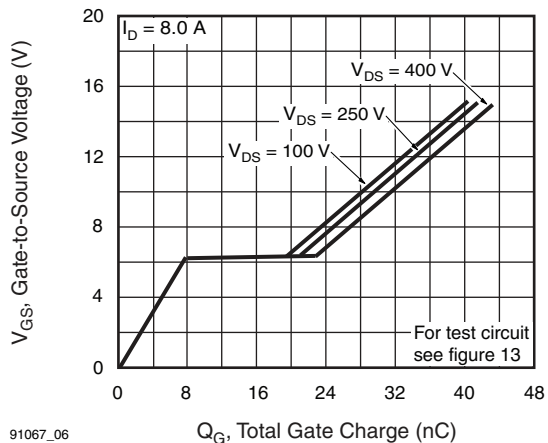
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Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



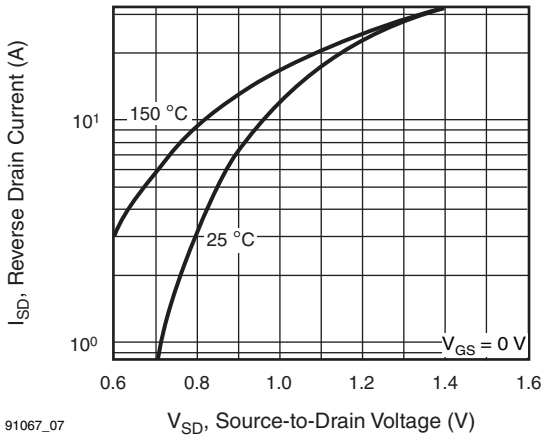
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Fig. 3 - Typical Transfer Characteristics



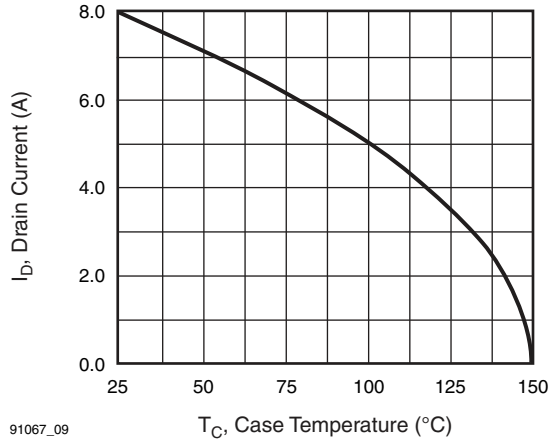
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Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



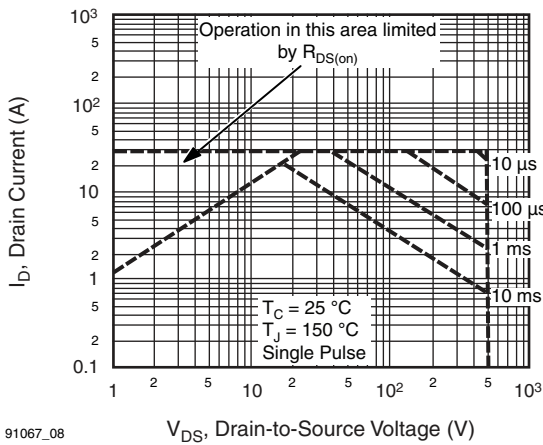
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Fig. 7 - Typical Source-Drain Diode Forward Voltage



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Fig. 9 - Maximum Drain Current vs. Case Temperature



91067_08

Fig. 8 - Maximum Safe Operating Area

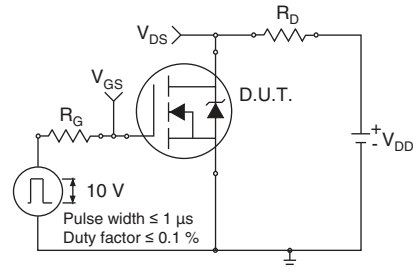


Fig. 10a - Switching Time Test Circuit

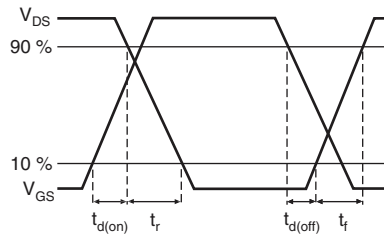
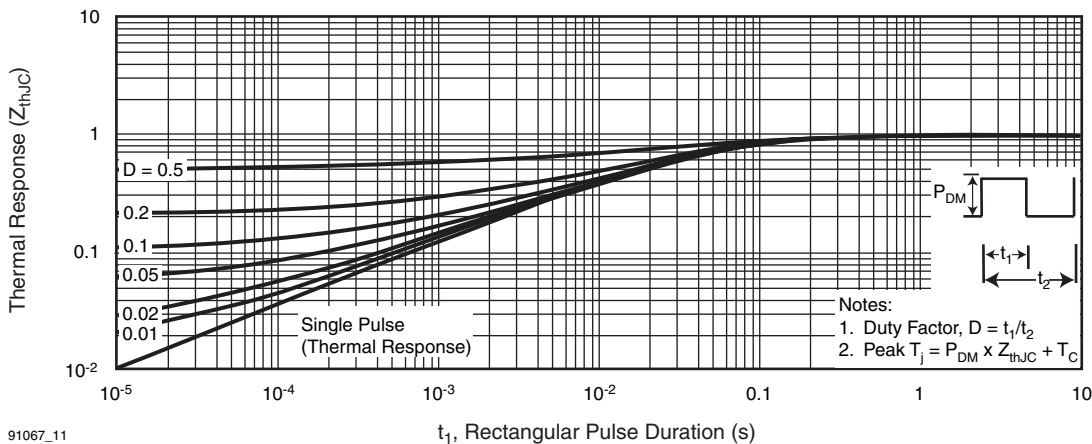


Fig. 10b - Switching Time Waveforms



91067_11

Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

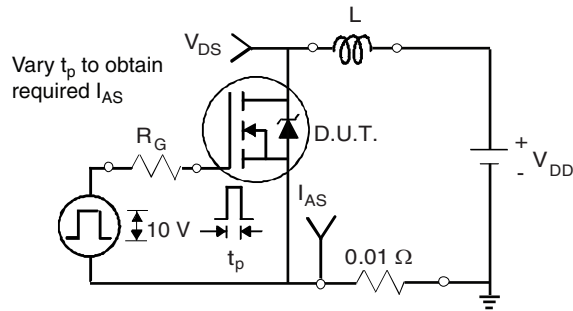


Fig. 12a - Unclamped Inductive Test Circuit

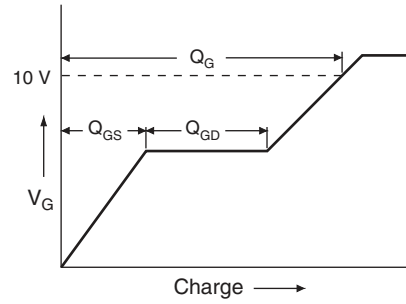


Fig. 13a - Basic Gate Charge Waveform

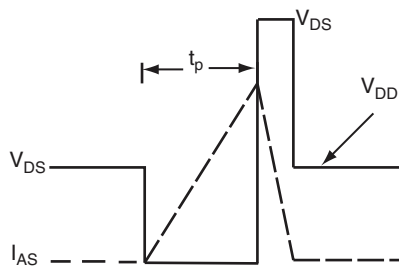


Fig. 12b - Unclamped Inductive Waveforms

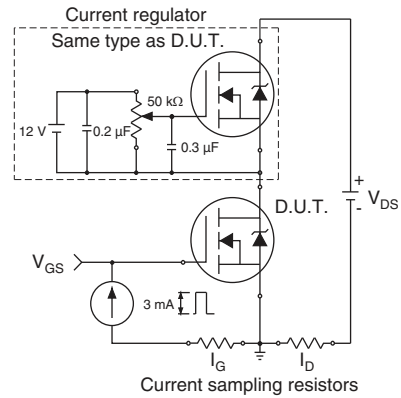
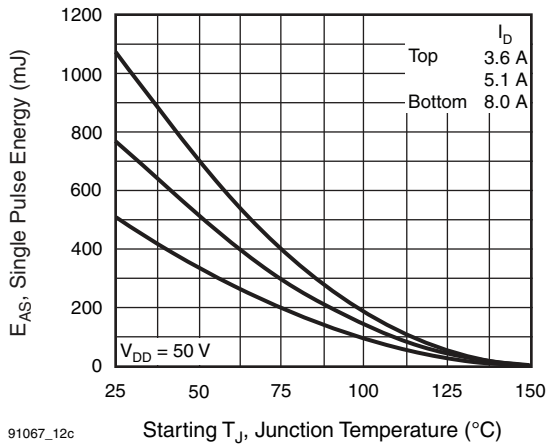


Fig. 13b - Gate Charge Test Circuit



91067_12c

Fig. 12c - Maximum Avalanche Energy vs. Drain Current

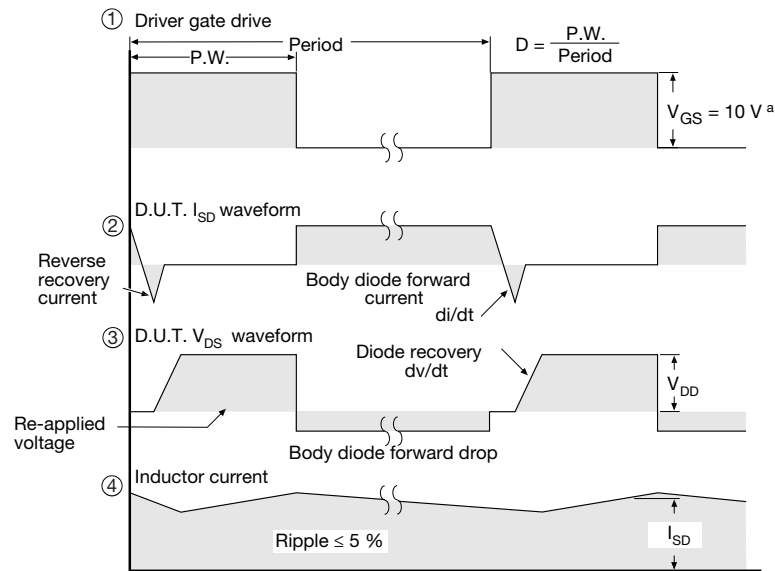
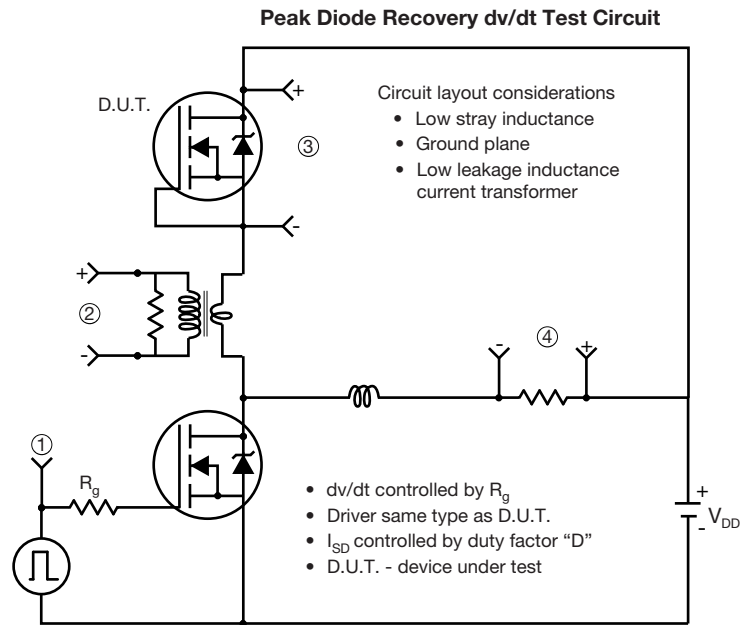


Fig. 14 - For N-Channel

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